

Stepwise Sulfurization from MoO₃ to MoS₂ via Chemical Vapor Deposition

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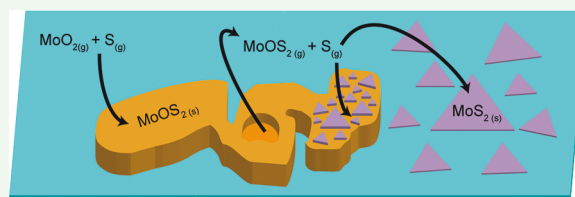
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Supporting Information

ABSTRACT: Chemical vapor deposition (CVD) is used widely to synthesize monolayer and few-layer transition metal dichalcogenide molybdenum disulfide (MoS₂), a two-dimensional (2D) material with various applications in nanoelectronics, catalysis, and optoelectronics. However, the CVD synthesis of 2D MoS₂ is highly sensitive to small changes in growth parameters and the growth mechanism has not been extensively studied. This work systematically investigates the effect of sulfur concentration on CVD synthesis of MoS₂ using molybdenum trioxide (MoO₃) and sulfur precursors. We find that with increasing concentration of sulfur vapor, intermediate products of molybdenum dioxide (MoO₂) and molybdenum oxysulfide (MoOS₂) can form during a stepwise sulfurization of MoO₃ to the final product of MoS₂. The intermediate MoOS₂, formed due to sulfur vapor deficiency, can be fully converted to MoS₂ with further sulfurization. We show that the local sulfur to molybdenum vapor ratio at the growth substrate critically determines the growth products. This study thus highlights the importance of keeping the molar ratio of sulfur to molybdenum vapor well in excess of the stoichiometrically required ratio of 3.5:1 in order to grow 2D MoS₂.

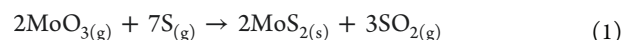
KEYWORDS: molybdenum disulfide, chemical vapor deposition, sulfurization, growth mechanism, molybdenum oxysulfide, molybdenum oxide



Atomically thin transition metal dichalcogenides (TMDs) are two-dimensional (2D) materials with the formula MX₂, where M is a transition metal and X is a chalcogen, such as S, Se, or Te. They have been the subject of great interest due to their physical, chemical, and electronic properties with applications for field-effect transistors,^{1–3} optoelectronic devices,^{4–6} and catalysis.^{7–10} The layer-dependent bandgap and attractive mechanical properties of the semiconducting TMD molybdenum disulfide (MoS₂) have created a demand for high-quality 2D crystals of MoS₂.^{11,12} A number of synthesis techniques have yielded thin MoS₂, including mechanical exfoliation,^{11,12} chemical exfoliation via intercalation,^{13–16} and molecular beam epitaxy;¹⁷ however the demand for controllable size, thickness, morphology, and scalability has led to the dominance of chemical vapor deposition. Chemical vapor deposition (CVD) is widely used to grow continuous thin films^{18–23} and triangular flakes,^{24–29} but the challenging nature of CVD continues to stimulate insightful research into the improvement of the technique. Recent works, such as the controlled growth of MoS₂ nanoribbons,³⁰ the synthesis of a large range of 2D TMDs via molten-salt assisted CVD growth,³¹ and in situ microscopy of the formation of edge-terminated MoS₂ on MoO₂ nanocrystals,³² have demonstrated the importance of understanding the growth mechanism.

Additionally, ab initio calculations of the defect density of synthesized MoS₂ indicate that CVD minimizes defects detrimental for electronic applications, further highlighting the importance of studying the CVD growth process.³³ The effects of pressure,³⁴ temperature,^{22,26,34–36} flow rate,³⁵ substrate seeding,^{19,29,37} reaction geometry,^{22,25,26,36–38} and Mo precursor concentration^{31,38,39} have been exhaustively studied with the aim of controlling the morphology and size of CVD-grown MoS₂. However, the role of sulfur concentration on MoS₂ growth has not been as extensively studied as other growth parameters.

Elemental sulfur (S) and molybdenum trioxide (MoO₃) powders are commonly used precursors for the CVD-growth of MoS₂ via the following sulfurization reaction:



The sulfur concentration is important in this reaction, with hexagonal or triangular MoS₂ flakes grown in sulfur deficient or excess conditions, respectively.^{34,38} In addition, incomplete sulfurization of MoO₃ can lead to the formation of

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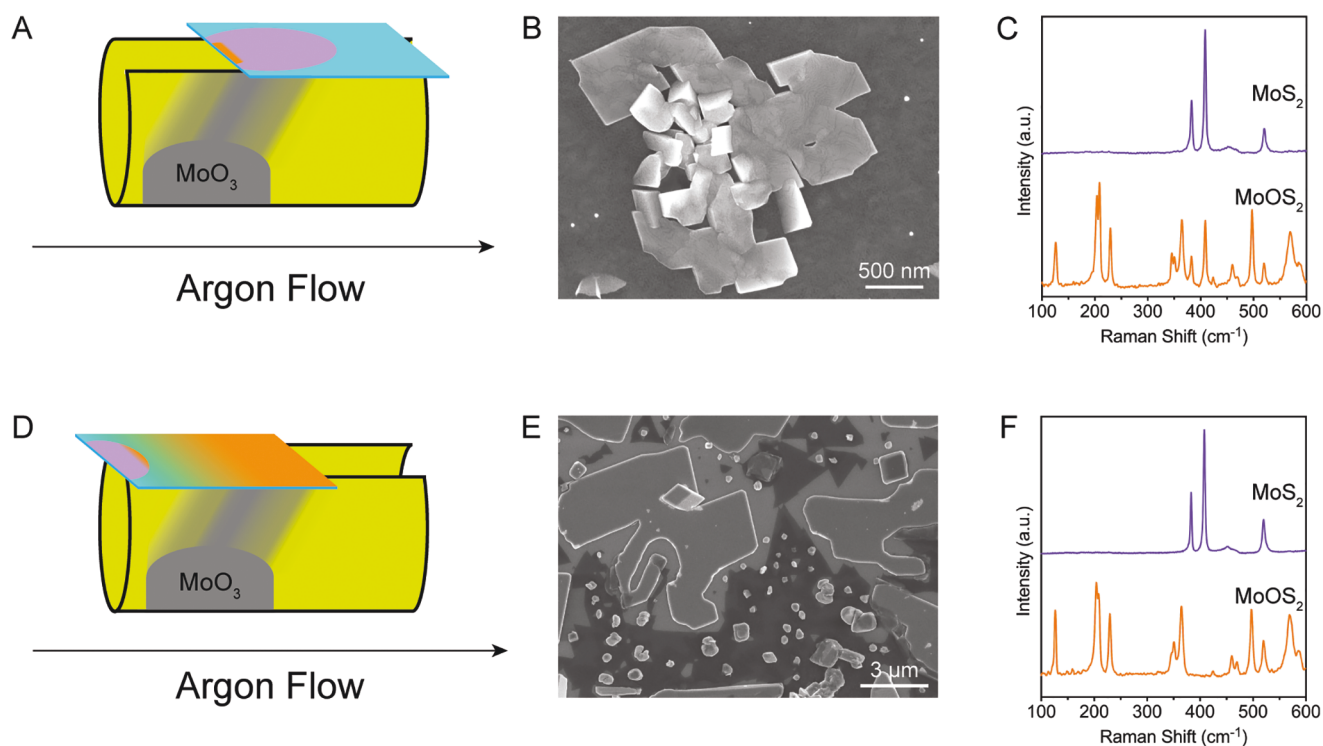


Figure 1. Local fluctuations in S:Mo ratio lead to the growth of intermediates. (A) Schematic diagram of locally increased Mo concentration at the leading edge of a substrate. On the substrate surface, blue, orange, and purple correspond to SiO₂, MoOS₂, and MoS₂, respectively. Beneath the substrate, yellow represents sulfur vapor and gray represents Mo vapor. (B) SEM image of MoOS₂ crystals formed at the front edge of the substrate. (C) Raman spectra of the MoS₂ film (top) and MoOS₂ crystals (bottom). The peak at 520 cm⁻¹ corresponds to the Si growth substrate. (D) Schematic diagram of locally decreased Mo concentration at the leading edge of a substrate. On the substrate surface, blue, orange, and purple correspond to SiO₂, MoOS₂, and MoS₂, respectively. Beneath the substrate, yellow represents sulfur vapor and gray represents Mo vapor. (E) SEM image of triangular MoS₂ crystals growing between MoOS₂ crystals. (F) Raman spectra of the MoS₂ crystals (top) and MoOS₂ crystals (bottom). The peak at 520 cm⁻¹ corresponds to the Si growth substrate.

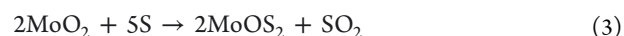
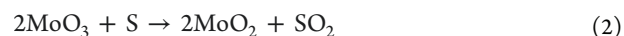
molybdenum oxides (MoO_{3-x})^{40–43} and molybdenum oxysulfides (MoO_{3-x}S_y; 0 ≤ x ≤ 3; 0 ≤ y ≤ 2).^{44,45} While the effect of sulfur concentration on the CVD growth of these intermediates and MoS₂ has been previously reported,^{34,38} a systematic investigation of the complete reaction pathway from MoO₃ to MoS₂ during the CVD process has yet to be undertaken. The lack of consensus as to the optimal growth parameters increases the necessity for a thorough understanding of the sulfurization mechanism in order to avoid the undesirable growth of molybdenum oxides and oxysulfides.

In this study, we report the effect of sulfur concentration on the CVD-growth of MoS₂. By varying the local and global sulfur concentrations across the growth substrate surface, we selectively grow molybdenum dioxide (MoO₂), MoOS₂, and MoS₂. Chemical and structural characterization of these species reveals a stepwise sulfurization mechanism to convert MoO₃ into MoS₂. The direct observation of hybrid oxysulfide/sulfide species and the conversion of MoOS₂ crystals into MoS₂ reveal a growth mechanism whereby oxysulfides can serve as crystalline intermediates that are sulfurized to form MoS₂. Our results demonstrate that to grow MoS₂ and avoid contaminating intermediate species via CVD, maintaining an excess of sulfur vapor is necessary to push the sulfurization of MoO₃ to completion.

RESULTS AND DISCUSSION

The CVD-growth of MoS₂ on a SiO₂ substrate was studied using MoO₃ and sulfur powder precursors placed inside a

single-zone tube furnace as outlined in Figure S1 in Supporting Information. The reaction proceeds as a stepwise sulfurization process described by three intermediate reactions:



In reaction 2, sulfur binds to oxygen to form SO₂ gas and a MoO₂ intermediate. The removal of a second oxygen and formation of two S–Mo bonds in reaction 3 yield an oxysulfide species, MoOS₂. The further removal of an oxygen from MoOS₂ yields MoS₂. Since both intermediate species are stable, incomplete sulfurization will lead to the formation of solid MoO₂ or MoOS₂. The oxide intermediate has been observed in the sulfurization of MoO₃ by H₂S gas,⁴⁰ and the oxysulfide intermediate has also been observed.^{34,38,45} In total, reaction 1 requires a stoichiometric ratio of 3.5 mol of S to 1 mol of Mo to completely form MoS₂.

The gas-phase reaction of sulfur and MoO₃ vapors is controlled by the local effective molar ratio of S:Mo at the substrate surface. The effective molar ratio at the leading edge of the substrate can be modified by changing the placement of the precursors in relation to the substrate. We fixed the global S:Mo molar loading ratio at 227:1 to grow MoS₂ and placed the substrate 8 mm downstream of the MoO₃ powder (Figure 1A). This geometry lowers the S:Mo molar ratio at the leading edge of the substrate because it is closest to the MoO₃ powder.

While a MoS₂ thin film grew across most of the substrate, small crystals were found within 100 μm of the front edge of the substrate closest to the MoO₃ precursor. These small crystals are irregularly shaped polyhedra (scanning electron micrograph (SEM), Figure 1B), which is uncharacteristic of MoS₂ crystals.^{24–29} The Raman spectrum of the small crystals (Figure 1C, bottom) shows the E_{2g} and A_{1g} peaks of MoS₂^{46,47} but also contains a number of peaks that cannot be attributed to the MoO₃ or S precursors (Figure S2). These peaks are consistent with reported spectra of MoOS₂^{34,38} and can be attributed to Raman modes arising from vibrations of Mo–S and Mo–O bonds (Table S1),^{48–52} revealing these small crystals to be the intermediate MoOS₂. The Raman spectrum of the surrounding film shows the expected MoS₂ spectrum (Figure 1C, top).^{46,47} This indicates that despite the globally high S:Mo molar ratio, the S:Mo molar ratio can change locally across the substrate due to the poor vapor transport of MoO₃.

To test the opposite effect, we fixed the global S:Mo molar loading ratio at 17:1 to favor the growth of the intermediate product MoOS₂ and placed the substrate directly over the MoO₃ powder (Figure 1D). Due to the flow of carrier gas, the MoO₃ vapor was pushed toward the center and far edge of the substrate, leading to a locally increased S:Mo molar ratio at the front edge of the substrate. Consequently, despite the low S:Mo molar loading ratio, MoS₂ clusters still formed at the front edge of the substrate. SEM analysis of the interface between the MoS₂ and MoOS₂ in Figure 1E reveals that triangular MoS₂ crystals grew between the irregularly shaped MoOS₂ crystals. Raman spectra from the film closest to the front edge of the substrate show the characteristic peaks for MoS₂ (Figure 1F, top), while spectra from the irregular crystals in the interface region show characteristic peaks of MoOS₂ (Figure 1F, bottom). The two experiments outlined in Figure 1 demonstrate that local fluctuations in the S:Mo ratio at the substrate surface allow for the formation of products heavily disfavored by the global conditions in the growth furnace.

The effect of the global S:Mo molar ratio was investigated with substrates placed directly above the MoO₃ powder. We changed the constant effective ratio across the substrate surface by varying the amount of sulfur precursor compared to MoO₃. The global S:Mo molar ratio increases with an increasing molar loading ratio, and representative optical images of crystals grown under increasing loading ratios are presented in Figure 2A–C. With a S:Mo molar loading ratio of 3:1, small rhomboid crystals with edge lengths between 1 and 5 μm formed (Figure 2A). The morphology⁵³ and Raman spectrum of these crystals are consistent with crystalline MoO₂ (Figure 2D top, Table S1).^{48,50–55} Under these sulfur-deficient conditions, reaction 2 dominates, favoring the formation of MoO₂. Increasing the S:Mo molar loading ratio to 7:1 yielded large irregularly shaped orange crystals (Figure 2B). The Raman spectrum of these crystals is consistent with that of MoOS₂, while the absence of the silicon peak at 520 cm⁻¹ indicates that they are thick (Figure 2D middle, Table S1). With the increase in sulfur concentration, both reactions 2 and 3 occur, favoring the formation of MoOS₂. Increasing the loading ratio to greater than 200:1 ensured a constant effective S:Mo molar ratio exceeding 3.5:1 throughout the entire growth. This allows for the complete stepwise sulfurization of MoO₃ through reactions 2–4, yielding triangular crystals of MoS₂ (Figure 2C,D bottom, Table S1). Increasing the reaction temperature also changes the global S:Mo ratio by increasing the vapor pressure of MoO₃ and S. We grew continuous films

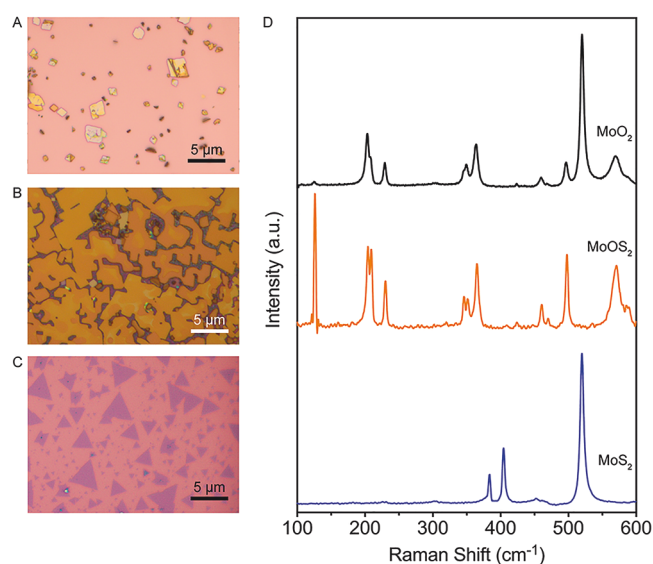


Figure 2. Modulation of global sulfur concentration controls the sulfurization of MoO₃. (A) Optical image of MoO₂ crystals grown under a S:Mo molar loading ratio of 3:1. (B) Optical image of MoOS₂ crystals grown under a S:Mo molar loading ratio of 7:1. (C) Optical image of MoS₂ crystals grown under a S:Mo molar loading ratio in excess of 200:1. (D) Raman spectra of the crystals corresponding to MoO₂ (top), MoOS₂ (middle), and MoS₂ (bottom). The peak at 520 cm⁻¹ corresponds to the Si growth substrate.

of MoS₂ at higher growth temperatures and showed that trace amounts of MoOS₂ were still observable at molar loading ratios of 187:1 (Figure S3). This indicates that higher concentrations of MoO₃ vapor were present at higher growth temperatures.

Closer examination of the CVD-grown MoOS₂ suggests that MoOS₂ can be further sulfurized to form MoS₂. Figure 3A shows a cluster of MoOS₂ crystals that display a color gradient, from orange to blue and white. The orange to blue color changing region was examined with SEM, which shows the optical color change as contrast change (Figure 3B). Figure 3C reveals triangular growth boundaries at the boundary of the contrast change, indicating the boundary is between the triangular MoS₂ and the intermediate MoOS₂. The X-ray photoelectron spectroscopy (XPS) analysis of this cluster is shown in Figures 3D and S4. The O 1s spectrum contains a main peak originating from the SiO₂ substrate⁵⁶ but also contains a smaller peak at lower binding energy originating from the Mo–O bonds of MoOS₂ (Figure 3D, left).⁵⁷ Two overlapping doublets are observed in the Mo 3d spectrum, corresponding to the 3d_{3/2} and 3d_{5/2} peaks of Mo⁴⁺ and Mo⁶⁺ (Figure 3D, right).^{58,59} The 4+ oxidation state of Mo suggests that MoS₂ is present in this cluster.¹⁹ The mixture of 4+ and 6+ oxidation states can also indicate the presence MoOS₂.^{58,59}

To further probe the chemistry of this cluster, a microscope-directed laser was used to collect Raman spectra from 532 nm regions of individual crystals. Raman spectroscopy confirms that the blue-white crystals are MoS₂, while the irregularly shaped orange crystals are MoOS₂ (Figure 3E). The Raman spectrum from the purple regions contains all of the peaks from MoOS₂ and MoS₂ (Figure 3E). This provides direct evidence for the presence of MoOS₂/MoS₂ hybrid crystals in the transition regions. Hybrid crystals were also observed at a S:Mo molar loading ratio of 17:1 in a cluster containing all three species (Figure S5). The triangular growth boundaries

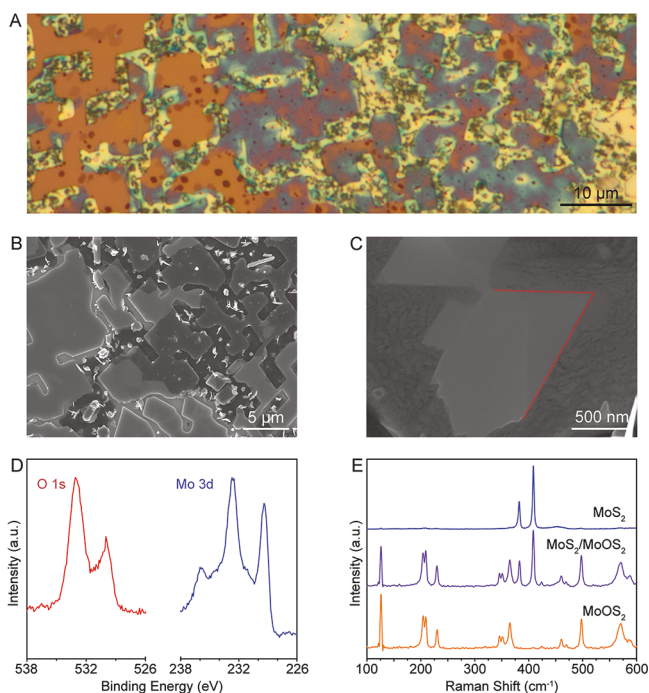


Figure 3. Characterization of MoOS₂/MoS₂ hybrid crystals. (A) Optical image of MoOS₂ crystals (orange) transitioning to MoS₂ crystals (blue-white). Hybrid MoOS₂/MoS₂ crystals are also observed (purple). (B) SEM image of MoOS₂ crystals (light) transitioning to MoS₂ (dark). (C) SEM image of the boundary between MoOS₂ (light) and MoS₂ (dark). The boundary denoted by the dotted red line highlights the characteristic triangular morphology of MoS₂. (D) XPS spectra of the O 1s peaks (left) and Mo 3d peaks (right) from the cluster shown in (A). (E) Raman spectra of MoS₂ originating from the blue and blue-white crystals (top), hybrid MoOS₂/MoS₂ species originating from the interfacial region of orange/purple crystals (middle), and MoOS₂ from the orange crystals (bottom).

present in the hybrid crystals suggest MoOS₂ serves a growth substrate for MoS₂ similar to reported CVD growth of MoS₂ on top of MoO_x under sulfur deficient conditions.⁶⁰

To determine if MoOS₂ acts a growth substrate, we analyzed the hybrid crystals using atomic force microscopy (AFM). Figures 4A and S6A show the interface between MoOS₂ and MoS₂, revealing deep pits in the MoOS₂ surface and layered MoS₂ triangular domains growing next to the MoOS₂ pits. These pits are not present in the orange MoOS₂ crystals further away from the interfacial region (Figure S6B), and the purple region of MoS₂ is revealed to be comprised of layers of triangular crystals (Figure S6C). The presence of the pits at the interface between MoOS₂ and MoS₂ suggests a growth mechanism through which solid MoOS₂ is consumed during the adjacent growth of MoS₂. To confirm this mechanism, MoO₃ was sulfurized under sulfur deficient conditions, yielding irregularly shaped orange and purple MoOS₂ crystals (Figure 4B top and Figure S7). These crystals were then sulfurized in the absence of any Mo precursor. The crystals shrunk in size and changed color to blue-white (Figure 4B, bottom). Raman spectroscopy confirmed that these blue-white crystals were MoS₂ (Figure S7). A few isolated crystals retained orange regions, which were found to be hybrid MoOS₂/MoS₂ species via Raman spectroscopy (Figure S7). Examination of these hybrid regions with AFM revealed deep pits (Figure 4C). SEM and Raman analysis shows that the purple triangular flakes that

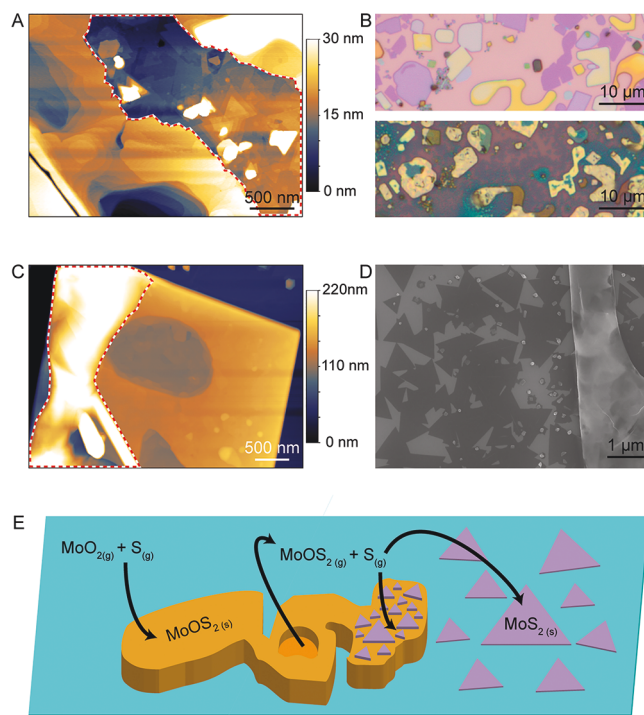


Figure 4. Sulfurization of MoOS₂ to form MoS₂. (A) Representative AFM image of the transition region between MoOS₂ and MoS₂ (encircled by the red/white dashed line). The MoS₂ region is characterized by the growth of layered triangular crystals, while the MoOS₂ region contains deep pits. (B) Optical images of MoOS₂ crystals grown under sulfur deficient conditions before (top) and after (bottom) sulfurization. (C) AFM image of the transition region between MoOS₂ and MoS₂ in a crystal shown in (B). The region on the left encircled by the red/white dashed line corresponds to MoS₂, while the deep pit and smooth right portion of the crystal correspond to MoOS₂. (D) SEM image of triangular MoS₂ crystals growing around the sulfurized crystals in (B). (E) Schematic of the stepwise sulfurization of MoO₃ to form MoS₂ via a crystalline MoOS₂ intermediate.

grew on the substrate during the second sulfurization are MoS₂ (Figures 4D and S7).

On the basis of reaction 4, MoOS₂ is an intermediate to the formation of MoS₂, so we propose the stepwise sulfurization detailed in Figure 4E. MoO₃ vapor reacts with sulfur vapor to first form MoO₂, which is further sulfurized to form MoOS₂ crystals. These intermediate MoOS₂ crystals can be vaporized, further sulfurized, and then recrystallized as MoS₂ nearby. This is consistent with reported conversion of MoO₂ nanocrystals into MoS₂ via CVD sulfurization.⁵³ The SiO₂ growth substrates used in growth of these species are amorphous, so we investigated the sulfurization of MoO₃ using crystalline fluorophlogopite (mica) substrates. Using molar loading ratios of 0.2:1, 8:1, and greater than 200:1, we selectively grew MoO₂, MoOS₂, and MoS₂ on mica (Figure S8), suggesting that the stepwise sulfurization of MoO₃ to MoS₂ is applicable to both amorphous and crystalline growth substrates. Our experiments demonstrate that it is essential to maintain a S:Mo ratio of 3.5:1 at the substrate surface during the entire growth process in order to bypass this stepwise growth pathway. While there likely exists a minimum S:Mo loading ratio required to push reaction 1 to completion, we did not determine this ratio. Due to the complexity of the CVD growth

process, any optimized loading ratio would only apply to a specific set of growth conditions and would not easily translate to a different CVD apparatus.

An S:Mo loading ratio greater than 1500:1 maintained excess sulfur to selectively grow MoS₂. Sulfur was held at room temperature and moved into a 250 °C zone to vaporize only when the center of the furnace reached 650 °C, ensuring a constant supply of sulfur vapor to maintain a stable S:Mo ratio across the substrate during the entirety of the growth. A short growth time was used to synthesize triangular crystals of MoS₂ rather than continuous films which form from merged crystals.^{19,22,27,38} Optical microscopy and SEM analysis of the resulting crystals reveal that they are triangular with clean edges (Figure 5A,B). Raman and XPS characterization of these

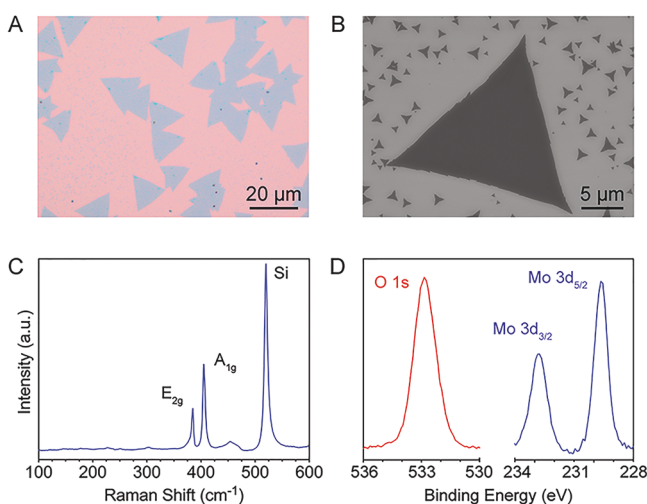


Figure 5. Characterization of MoS₂ crystals grown in excess sulfur. (A) Optical image of triangular MoS₂ crystals. The purple crystals are monolayer; however, some small blue regions indicate the beginning of multilayer growth on some crystals. (B) SEM image of the triangular crystals shown in (A). (C) Raman spectrum of the triangular crystals in (A) showing the E_{2g} and A_{1g} peaks of MoS₂. The peak at 520 cm⁻¹ corresponds to the Si growth substrate. (D) XPS spectra of the O 1s (left) and Mo 3d (right) peaks from the crystals in (A).

crystals confirms they are chemically pure MoS₂ (Figures 5C,D and S9),^{46,61} with no presence of MoOS₂.^{58,59} The 20 cm⁻¹ separation of the E_{2g} and A_{1g} peaks (Figure S9B) is consistent with reported values for monolayer CVD-grown MoS₂.^{35,37}

CONCLUSIONS

In summary, we report the stepwise sulfurization of MoO₃ to form MoS₂ via chemical vapor deposition. By controlling the local and global S:Mo molar ratio present in the gas-phase at the growth substrate surface, we have demonstrated that MoO₃ can be sulfurized to form MoO₂, then MoOS₂, and finally MoS₂ as a function of increasing sulfur vapor concentration. Characterization of MoOS₂/MoS₂ hybrid crystals and observation of the direct conversion of MoOS₂ crystals into MoS₂ reveal that MoOS₂ serves as an intermediate in the formation of MoS₂ and provide direct evidence for a stepwise sulfurization process. This mechanism underlines the importance of keeping sulfur in excess throughout CVD growth in order to synthesize chemically pure MoS₂, rather than the intermediate products. The increasing applications and interest in MoS₂ is creating a demand for synthesis techniques offering

control over thickness, morphology, and purity, necessitating further work to develop reproducible and robust chemical vapor deposition techniques.

EXPERIMENTAL METHODS

Chemical Vapor Deposition Synthesis of MoOS₂ and MoS₂. MoS₂ and MoOS₂ were synthesized inside a quartz tube (1 in. OD) placed in a Lindberg-Blue Mini-Mite single-zone tube furnace (ThermoFisher). Sulfur powder (99.5%, Alfa Aesar) was placed in a quartz holder that was placed 17.5 cm upstream of the center of the furnace. MoO₃ powder (99.97%, Sigma-Aldrich) was spread out over approximately a 1 cm region in a separate quartz holder, placed at the center of the furnace. Growth substrates of 300 nm SiO₂ on silicon were cut into 3 cm² sections and sonicated for 5 min each in acetone, isopropanol, and distilled H₂O. Substrates were then plasma cleaned for 5 min with an air plasma. Cleaned substrates were then placed face-down on top of the quartz holder directly above the MoO₃ powder. Substrates were placed 1–2 cm downstream of the MoO₃ powder only for the experiments investigating the effect of substrate placement (Figure 1).

The quartz tube was purged with argon gas (99.998% by volume, Airgas) for a minimum of 10 min at atmospheric pressure to remove oxygen. The argon gas was continuously flowed through the tube throughout the entire synthesis process at a flow rate ranging from 70 sccm to 100 sccm. The furnace was heated to a growth temperature of 650 °C at a rate of 15 °C per minute and then held at temperature for 10–20 min. During growth, the MoO₃ and substrate remained in a stable zone of 650 °C and the sulfur was held in a 250 °C zone 17.5 cm upstream. The furnace was then allowed to cool slowly to 400–300 °C and then opened to cool more rapidly to room temperature.

Sulfurization of MoOS₂ Crystals. Substrates with CVD-grown MoOS₂ were placed in a quartz tube placed in the center of a single-zone furnace. Sulfur (2.0 g) was placed in a 3 mL alumina combustion boat (CoorsTek) with the leading edge of the boat 19 cm upstream of the center of the furnace with a magnet placed further upstream of the combustion boat. The furnace was purged with 35 sccm of argon gas for 10 min and then heated to 630 °C at 15 °C per minute under argon gas flow. Sulfur was then pushed with the magnet to a 250 °C zone 17.5 cm upstream of the MoO₃. The furnace was further heated for 5 min yielding a temperature of 700 °C in the center and 275 °C 17.5 cm upstream. The furnace was then held at temperature for 10 min before being allowed to cool to room temperature.

Synthesis of Triangular MoS₂ Crystals. Sulfur powder (1.5 g) was placed in a 3 mL alumina combustion boat with the leading edge of the boat 19 cm upstream of the center of the furnace with a magnet placed further upstream of the combustion boat. MoO₃ powder (3.2 mg) was placed in a quartz holder with a substrate placed 12 mm directly above the MoO₃. The substrate was cleaned as described above and then treated with 2–5 μL of 10 μM aqueous hexamethylpararosaniline chloride (crystal violet, >90%, Sigma-Aldrich) spread out onto the surface with the side of a pipet tip and allowed to air-dry. The furnace was purged with 35 sccm of argon gas for 10 min and then heated to 650 °C at 15 °C per minute under argon gas flow. Sulfur was then pushed with the magnet to a 250 °C zone 17.5 cm upstream of the MoO₃. The furnace was further heated for 3 min yielding a temperature of 700 °C in the center and 275 °C 17.5 cm upstream. The furnace was then held at temperature for 5 min before being allowed to cool to room temperature.

Characterization. Optical images were taken with an Olympus BX51 microscope. Scanning electron micrographs were taken with a Hitachi SU8230 CFE SEM using a 10 kV accelerating voltage. Raman spectra were taken with a Horiba LabRAM HR Evolution spectrometer using a 2.5 mW 532 nm laser. The Raman peak of crystalline silicon at 520 cm⁻¹ was used as an internal standard for all Raman spectra. The X-ray photoelectron spectra were collected using a monochromatic 1486.7 eV Al Kα X-ray source on a PHI VersaProbe II X-ray photoelectron spectrometer with a 0.47 eV system resolution. The energy scale was calibrated using Cu 2p_{3/2} (932.67 eV) and Au 4f_{7/2} (84.00 eV) peaks on a clean copper plate and clean gold foil.

XPS spectra were normalized using the adventitious carbon C 1s peak at 284.5 eV. Atomic force microscopy images were taken with a Bruker Dimension Fastscan atomic force microscope using Fastscan B AFM tips (Bruker) at a scanning rate of 0.5–1.0 Hz.

■ ASSOCIATED CONTENT

🔗 Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsanm.8b01266.

Growth parameters for MoS₂, Raman spectra from standards of the reactants and products in the CVD growth of MoS₂, characterization of MoS₂ films grown under vacuum at 800 °C with different sulfur concentrations, XPS characterization of MoOS₂/MoS₂ hybrid crystals, characterization of MoOS₂/MoS₂ hybrid crystals grown under a S:Mo molar loading ratio of 17:1, AFM characterization of hybrid MoOS₂/MoS₂, Raman characterization of MoOS₂ crystals sulfurized in the absence of Mo precursor, characterization of MoO₂, MoOS₂, and MoS₂ grown on crystalline mica, characterization of MoS₂ crystals grown in excess sulfur, and identification of Raman modes present in spectra of MoO₂, MoOS₂, and MoS₂ (PDF)

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Notes

The authors declare no competing financial interest.

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■ REFERENCES

- (1) Kim, S.; Konar, A.; Hwang, W.-S.; Lee, J. H.; Lee, J.; Yang, J.; Jung, C.; Kim, H.; Yoo, J.-B.; Choi, J.-Y.; et al. High-Mobility and Low-Power Thin-Film Transistors Based on Multilayer MoS₂ Crystals. *Nat. Commun.* **2012**, *3*, 1011.
- (2) Radisavljevic, B.; Radenovic, A.; Brivio, J.; Giacometti, V.; Kis, A. Single-Layer MoS₂ Transistors. *Nat. Nanotechnol.* **2011**, *6*, 147–150.
- (3) Chhowalla, M.; Jena, D.; Zhang, H. Two-Dimensional Semiconductors for Transistors. *Nat. Rev. Mater.* **2016**, *1*, 16052.
- (4) Lee, H. S.; Min, S. W.; Chang, Y. G.; Park, M. K.; Nam, T.; Kim, H.; Kim, J. H.; Ryu, S.; Im, S. MoS₂ Nanosheet Phototransistors with Thickness-Modulated Optical Energy Gap. *Nano Lett.* **2012**, *12*, 3695–3700.
- (5) Wang, Q. H.; Kalantar-zadeh, K.; Kis, A.; Coleman, J. N.; Strano, M. S. Electronics and Optoelectronics of Two-Dimensional Transition Metal Dichalcogenides. *Nat. Nanotechnol.* **2012**, *7*, 699–712.

(6) Mak, K. F.; Shan, J. Photonics and Optoelectronics of 2D Semiconductor Transition Metal Dichalcogenides. *Nat. Photonics* **2016**, *10*, 216–226.

(7) Hinnemann, B.; Moses, P. G.; Bonde, J.; Jørgensen, K. P.; Nielsen, J. H.; Horch, S.; Chorkendorff, I.; Nørskov, J. K. Biomimetic Hydrogen Evolution: MoS₂ Nanoparticles as Catalyst for Hydrogen Evolution. *J. Am. Chem. Soc.* **2005**, *127*, 5308–5309.

(8) Jaramillo, T. F.; Jørgensen, K. P.; Bonde, J.; Nielsen, J. H.; Horch, S.; Chorkendorff, I. Identification of Active Edge Sites for Electrochemical H₂ Evolution from MoS₂ Nanocatalysts. *Science* **2007**, *317*, 100–102.

(9) Voiry, D.; Fullon, R.; Yang, J.; de Carvalho Castro e Silva, C.; Kappera, R.; Bozkurt, I.; Kaplan, D.; Lagos, M. J.; Batson, P. E.; Gupta, G.; et al. The Role of Electronic Coupling between Substrate and 2D MoS₂ Nanosheets in Electrocatalytic Production of Hydrogen. *Nat. Mater.* **2016**, *15*, 1003–1009.

(10) Zhou, Y.; Silva, J. L.; Woods, J. M.; Pondick, J. V.; Feng, Q.; Liang, Z.; Liu, W.; Lin, L.; Deng, B.; Brena, B.; et al. Revealing the Contribution of Individual Factors to Hydrogen Evolution Reaction Catalytic Activity. *Adv. Mater.* **2018**, *30*, 1706076.

(11) Splendiani, A.; Sun, L.; Zhang, Y.; Li, T.; Kim, J.; Chim, C. Y.; Galli, G.; Wang, F. Emerging Photoluminescence in Monolayer MoS₂. *Nano Lett.* **2010**, *10*, 1271–1275.

(12) Mak, K. F.; Lee, C.; Hone, J.; Shan, J.; Heinz, T. F. Atomically Thin MoS₂: A New Direct-Gap Semiconductor. *Phys. Rev. Lett.* **2010**, *105*, 2–5.

(13) Joensen, P.; Frindt, R. F.; Morrison, S. R. Single-Layer MoS₂. *Mater. Res. Bull.* **1986**, *21*, 457–461.

(14) Heising, J.; Kanatzidis, M. G. Structure of Restacked MoS₂ and WS₂ Elucidated by Electron Crystallography. *J. Am. Chem. Soc.* **1999**, *121*, 638–643.

(15) Coleman, J. N.; Lotya, M.; O'Neill, A.; Bergin, S. D.; King, P. J.; Khan, U.; Young, K.; Gaucher, A.; De, S.; Smith, R. J.; et al. Two-Dimensional Nanosheets Produced by Liquid Exfoliation of Layered Materials. *Science* **2011**, *331*, 568–571.

(16) Nicolosi, V.; Chhowalla, M.; Kanatzidis, M. G.; Strano, M. S.; Coleman, J. N. Liquid Exfoliation of Layered Materials. *Science* **2013**, *340*, 72–75.

(17) Fu, D.; Zhao, X.; Zhang, Y.-Y.; Li, L.; Xu, H.; Jang, A.-R.; Yoon, S. I.; Song, P.; Poh, S. M.; Ren, T.; et al. Molecular Beam Epitaxy of Highly Crystalline Monolayer Molybdenum Disulfide on Hexagonal Boron Nitride. *J. Am. Chem. Soc.* **2017**, *139*, 9392–9400.

(18) Zhan, Y.; Liu, Z.; Najmaei, S.; Ajayan, P. M.; Lou, J. Large-Area Vapor-Phase Growth and Characterization of MoS₂ Atomic Layers on a SiO₂ Substrate. *Small* **2012**, *8*, 966–971.

(19) Lee, Y. H.; Zhang, X. Q.; Zhang, W.; Chang, M. T.; Lin, C. T.; Chang, K. D.; Yu, Y. C.; Wang, J. T. W.; Chang, C. S.; Li, L. J.; et al. Synthesis of Large-Area MoS₂ Atomic Layers with Chemical Vapor Deposition. *Adv. Mater.* **2012**, *24*, 2320–2325.

(20) Yu, Y.; Li, C.; Liu, Y.; Su, L.; Zhang, Y.; Cao, L. Controlled Scalable Synthesis of Uniform, High-Quality Monolayer and Few-Layer MoS₂ Films. *Sci. Rep.* **2013**, *3*, 1866.

(21) Choudhary, N.; Park, J.; Hwang, J. Y.; Choi, W. Growth of Large-Scale and Thickness-Modulated MoS₂ Nanosheets. *ACS Appl. Mater. Interfaces* **2014**, *6*, 21215–21222.

(22) Wang, S.; Pacios, M.; Bhaskaran, H.; Warner, J. H. Substrate Control for Large Area Continuous Films of Monolayer MoS₂ by Atmospheric Pressure Chemical Vapor Deposition. *Nanotechnology* **2016**, *27*, 085604.

(23) Yu, H.; Liao, M.; Zhao, W.; Liu, G.; Zhou, X. J.; Wei, Z.; Xu, X.; Liu, K.; Hu, Z.; Deng, K.; et al. Wafer-Scale Growth and Transfer of Highly-Oriented Monolayer MoS₂ Continuous Films. *ACS Nano* **2017**, *11*, 12001–12007.

(24) Bilgin, I.; Liu, F.; Vargas, A.; Winchester, A.; Man, M. K. L.; Upmanyu, M.; Dani, K. M.; Gupta, G.; Talapatra, S.; Mohite, A. D.; et al. Chemical Vapor Deposition Synthesized Atomically Thin Molybdenum Disulfide with Optoelectronic-Grade Crystalline Quality. *ACS Nano* **2015**, *9*, 8822–8832.

- (25) Tu, Z.; Li, G.; Ni, X.; Meng, L.; Bai, S.; Chen, X.; Lou, J.; Qin, Y. Synthesis of Large Monolayer Single Crystal MoS₂ Nanosheets with Uniform Size through a Double-Tube Technology. *Appl. Phys. Lett.* **2016**, *109*, 223101.
- (26) Kurabayashi, S.; Nagashio, K. Transport Properties of the Top and Bottom Surfaces in Monolayer MoS₂ Grown by Chemical Vapor Deposition. *Nanoscale* **2017**, *9* (35), 13264.
- (27) van der Zande, A. M.; Huang, P. Y.; Chenet, D. A.; Berkelbach, T. C.; You, Y.; Lee, G.-H.; Heinz, T. F.; Reichman, D. R.; Muller, D. A.; Hone, J. C. Grains and Grain Boundaries in Highly Crystalline Monolayer Molybdenum Disulfide. *Nat. Mater.* **2013**, *12*, 554–561.
- (28) Wu, S.; Huang, C.; Aivazian, G.; Ross, J. S.; Cobden, D. H.; Xu, X. Vapor-Solid Growth of High Optical Quality MoS₂ Monolayers with near-Unity Valley Polarization. *ACS Nano* **2013**, *7*, 2768–2772.
- (29) Lee, Y. H.; Yu, L.; Wang, H.; Fang, W.; Ling, X.; Shi, Y.; Lin, C. Te; Huang, J. K.; Chang, M. T.; Chang, C. S.; et al. Synthesis and Transfer of Single-Layer Transition Metal Disulfides on Diverse Surfaces. *Nano Lett.* **2013**, *13*, 1852–1857.
- (30) Li, S.; Lin, Y.; Zhao, W.; Wu, J.; Wang, Z.; Hu, Z.; Shen, Y.; Tang, D.; Wang, J.; Zhang, Q.; et al. Vapour–Liquid–Solid Growth of Monolayer MoS₂ Nanoribbons. *Nat. Mater.* **2018**, *17*, 535–543.
- (31) Zhou, J.; Lin, J.; Huang, X.; Zhou, Y.; Chen, Y.; Xia, J.; Wang, H.; Xie, Y.; Yu, H.; Lei, J.; et al. A Library of Atomically Thin Metal Chalcogenides. *Nature* **2018**, *556*, 355–359.
- (32) Dahl-Petersen, C.; Saric, M.; Brorson, M.; Moses, G.; Rossmels, J.; Lauritsen, J. V.; Helveg, S. Topotactic Growth of Edge-Terminated MoS₂ from MoO₃ Nanocrystals. *ACS Nano* **2018**, *12*, 5351–5358.
- (33) Li, L.; Long, R.; Prezhdov, O. V. Why Chemical Vapor Deposition Grown MoS₂ Samples Outperform Physical Vapor Deposition Samples: Time-Domain ab Initio Analysis. *Nano Lett.* **2018**, *18*, 4008–4014.
- (34) Najmaei, S.; Liu, Z.; Zhou, W.; Zou, X.; Shi, G.; Lei, S.; Yakobson, B. I.; Idrobo, J.-C.; Ajayan, P. M.; Lou, J. Vapour Phase Growth and Grain Boundary Structure of Molybdenum Disulfide Atomic Layers. *Nat. Mater.* **2013**, *12*, 754–759.
- (35) Wang, S.; Rong, Y.; Fan, Y.; Pacios, M.; Bhaskaran, H.; He, K.; Warner, J. H. Shape Evolution of Monolayer MoS₂ Crystals Grown by Chemical Vapor Deposition. *Chem. Mater.* **2014**, *26*, 6371–6379.
- (36) Xie, S.; Xu, M.; Liang, T.; Huang, G.; Wang, S.; Xue, G.; Meng, N.; Xu, Y.; Chen, H.; Ma, X.; et al. A High-Quality Round-Shaped Monolayer MoS₂ Domain and Its Transformation. *Nanoscale* **2016**, *8*, 219–225.
- (37) Ling, X.; Lee, Y. H.; Lin, Y.; Fang, W.; Yu, L.; Dresselhaus, M. S.; Kong, J. Role of the Seeding Promoter in MoS₂ Growth by Chemical Vapor Deposition. *Nano Lett.* **2014**, *14*, 464–472.
- (38) Senthilkumar, V.; Tam, L. C.; Kim, Y. S.; Sim, Y.; Seong, M. J.; Jang, J. I. Direct Vapor Phase Growth Process and Robust Photoluminescence Properties of Large Area MoS₂ Layers. *Nano Res.* **2014**, *7*, 1759–1768.
- (39) Lim, Y. F.; Priyadarshi, K.; Bussolotti, F.; Gogoi, P. K.; Cui, X.; Yang, M.; Pan, J.; Tong, S. W.; Wang, S.; Pennycook, S. J.; et al. Modification of Vapor Phase Concentrations in MoS₂ Growth Using a NiO Foam Barrier. *ACS Nano* **2018**, *12*, 1339–1349.
- (40) Li, X. L.; Li, Y. D. Formation of MoS₂ Inorganic Fullerenes (IFs) by the Reaction of MoO₃ Nanobelts and S. *Chem. - Eur. J.* **2003**, *9*, 2726–2731.
- (41) Arnoldy, P.; van den Heijkant, J. A. M.; De Bok, G. D.; Moulign, J. A. Temperature-Programmed Sulfiding of MoO₃/Al₂O₃ Catalysts. *J. Catal.* **1985**, *92*, 35–55.
- (42) Okamoto, Y.; Kato, A.; Usman; Rinaldi, N.; Fujikawa, T.; Koshika, H.; Hiromitsu, I.; Kubota, T. Effect of Sulfidation Temperature on the Intrinsic Activity of Co-MoS₂ and Co-WS₂ Hydrodesulfurization Catalysts. *J. Catal.* **2009**, *265*, 216–228.
- (43) Wu, Z.; Wang, D.; Sun, A. Preparation of MoS₂ Nanoflakes by a Novel Mechanical Activation Method. *J. Cryst. Growth* **2010**, *312*, 340–343.
- (44) Muijsers, J. C.; Weber, T.; Vanhardeveld, R. M.; Zandbergen, H. W.; Niemantsverdriet, J. W. Sulfidation Study of Molybdenum Oxide Using MoO₃/SiO₂/Si(100) Model Catalysts and Mo^{IV}-Sulfur Cluster Compounds. *J. Catal.* **1995**, *157*, 698–705.
- (45) Weber, T.; Muijsers, J. C.; van Wolput, J. H. M. C.; Verhagen, C. P. J.; Niemantsverdriet, J. W. Basic Reaction Steps in the Sulfidation of Crystalline MoO₃ to MoS₂ as Studied by X-Ray Photoelectron and Infrared Emission Spectroscopy. *J. Phys. Chem.* **1996**, *100*, 14144–14150.
- (46) Li, S. L.; Miyazaki, H.; Song, H.; Kuramochi, H.; Nakaharai, S.; Tsukagoshi, K. Quantitative Raman Spectrum and Reliable Thickness Identification for Atomic Layers on Insulating Substrates. *ACS Nano* **2012**, *6*, 7381–7388.
- (47) Lee, C.; Yan, H.; Brus, L.; Heinz, T.; Hone, J.; Ryu, S. Anomalous Lattice Vibrations of Single- and Few-Layer MoS₂. *ACS Nano* **2010**, *4*, 2695–2700.
- (48) Wu, H.; Zhou, X.; Li, J.; Li, X.; Li, B.; Fei, W.; Zhou, J.; Yin, J.; Guo, W. Ultrathin Molybdenum Dioxide Nanosheets as Uniform and Reusable Surface-Enhanced Raman Spectroscopy Substrates with High Sensitivity. *Small* **2018**, *14*, 1802276.
- (49) Schrader, G. L.; Cheng, C. P. In Situ Laser Raman Spectroscopy of the Sulfiding of MO/γ-Al₂O₃ Catalysts. *J. Catal.* **1983**, *80*, 369–385.
- (50) Dieterle, M.; Mestl, G. Raman Spectroscopy of Molybdenum Oxides. *Phys. Chem. Chem. Phys.* **2002**, *4*, 822–826.
- (51) Camacho-López, M. A.; Escobar-Alarcón, L.; Picquart, M.; Arroyo, R.; Córdoba, G.; Haro-Poniatowski, E. Micro-Raman Study of the m-MoO₃ to α-MoO₃ Transformation Induced by cw-Laser Irradiation. *Opt. Mater.* **2011**, *33*, 480–484.
- (52) Çakır, D.; Peeters, F. M.; Sevik, C. Mechanical and Thermal Properties of *h*-MX₂ (M = Cr, Mo, W; X = O, S, Se, Te) Monolayers: A Comparative Study. *Appl. Phys. Lett.* **2014**, *104*, 203110.
- (53) Wang, X.; Feng, H.; Wu, Y.; Jiao, L. Controlled Synthesis of Highly Crystalline MoS₂ Flakes by Chemical Vapor Deposition. *J. Am. Chem. Soc.* **2013**, *135*, 5304–5307.
- (54) Solferino, G.; Anderson, A. J. Thermal Reduction of Molybdenite and Hematite in Water and Hydrogen Peroxide-Bearing Solutions: Insights on Redox Conditions in Hydrothermal Diamond Anvil Cell (HDAC) Experiments. *Chem. Geol.* **2012**, *322–323*, 215–222.
- (55) Srivastava, R.; Chase, L. L. Raman Spectra of CrO₂ and MoO₂ Single Crystals. *Solid State Commun.* **1972**, *11*, 349–353.
- (56) Dang, T. A.; Chau, C. N. Electron Spectroscopy for Chemical Analysis of Cool White Phosphors Coated with SiO₂ Thin Film. *J. Electrochem. Soc.* **1996**, *143*, 302–305.
- (57) Anwar, M.; Hogarth, C.; Bulpitt, R. Effect of Substrate Temperature and Film Thickness on the Surface Structure of Some Thin Amorphous Films of MoO₃ Studied by X-Ray Photoelectron Spectroscopy (ESCA). *J. Mater. Sci.* **1989**, *24*, 3087–3090.
- (58) Benoist, L.; Gonbeau, D.; Pfister-Guillouzo, G.; Schmidt, E.; Meunier, G.; Levasseur, A. X-Ray Photoelectron Spectroscopy Characterization of Amorphous Molybdenum Oxysulfide Thin Films. *Thin Solid Films* **1995**, *258*, 110–114.
- (59) Qiao, Y.; Hu, X.; Liu, Y.; Liang, G.; Croft, M. C.; Huang, Y. Surface Modification of MoO_xS_y on Porous TiO₂ Nanospheres as an Anode Material with Highly Reversible and Ultra-Fast Lithium Storage Properties. *J. Mater. Chem. A* **2013**, *1*, 15128.
- (60) Wu, C. R.; Chang, X. R.; Wu, C. H.; Lin, S. Y. The Growth Mechanism of Transition Metal Dichalcogenides by Using Sulfurization of Pre-Deposited Transition Metals and the 2D Crystal Hetero-Structure Establishment. *Sci. Rep.* **2017**, *7*, 42146.
- (61) Lin, Y.-C.; Lu, N.; Perea-Lopez, N.; Li, J.; Lin, Z.; Peng, X.; Lee, C. H.; Sun, C.; Calderin, L.; Browning, P. N.; et al. Direct Synthesis of van Der Waals Solids. *ACS Nano* **2014**, *8*, 3715–3723.